Search Notes		
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tes	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/670,740	MIZUYOSHI, AKIRA	
	Examiner	Art Unit	
18011 SIBLI 8411 1481	Thao P. Le	2818	

	SEARCHED		
Class	Subclass	Date	Examiner
257	79	3/14/2005	T.LE
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
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